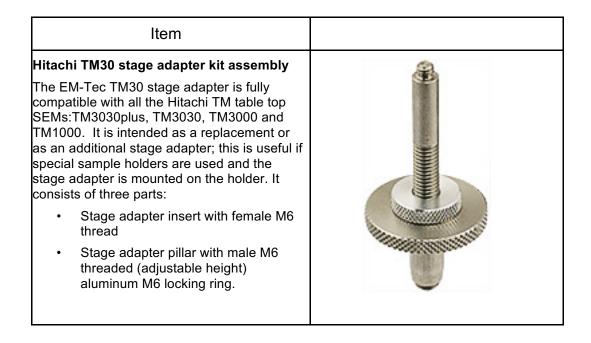


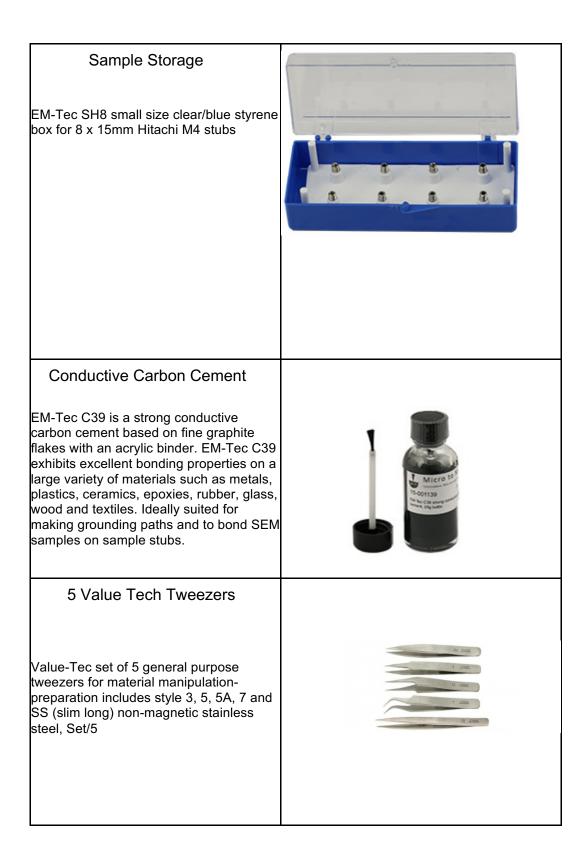
Hitachi TM Series User-Sample Preparation Kit

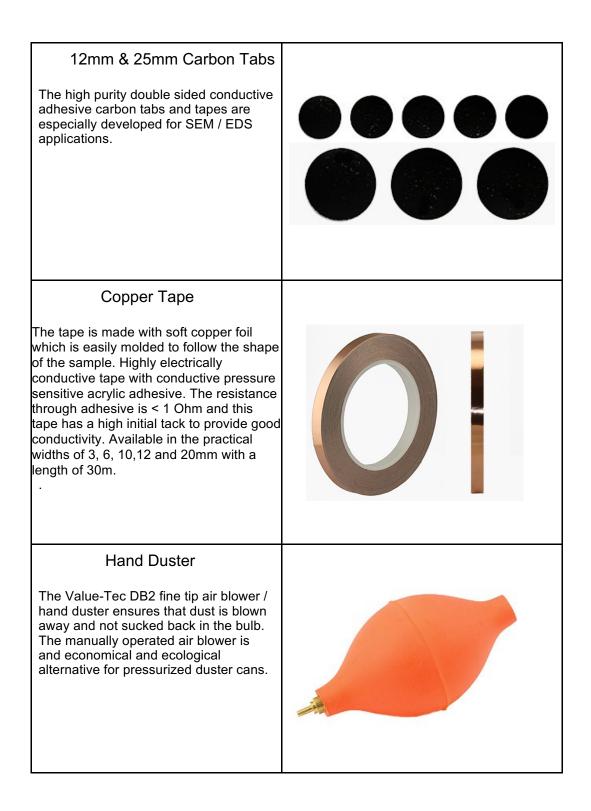
The Rave Scientific Hitachi TM Series user kit provides a flexible and easy way to purchase a comprehensive kit of the required basic sample preparation consumables and calibration standards. Standards are required for checking magnification, EDS and resolution in the electron microscope. All sample holders and standards are fully compatible with the Hitachi TM3030plus, TM3030, TM3000 & TM1000 tabletop SEM's. This kit also includes a set of 5 sample preparation tweezers, the Hitachi stage adapter assembly stage adapter, allowing any M4 designed sample holder to be compatible, 5 versatile sample holders, including the variable 0-90° angle tilt holder, valuable when there is no tilt option on your Hitachi system. The kit is also configured to be compatible with both pin stubs and Hitachi M4 stubs.



Item		
Mag calibration sample The Micro-Tec MTC-5 brigth field multiple target calibration standard comprises accurately deposited bright chromium lines on a conductive ultra- flat silicon substrate. The MTC-5 has been designed for calibrating reflective ligth microscopes, stereo microscopes, optical quality control systems and low magnification SEM imaging. The Micro- Tec MTC-5 incorporates four distinct patterns:		
EDS Calibration Standard The EM-Tec CXS-5LE calibration standard includes 5 reference materials and a 200µm aperture copper Faraday cup. All mounted in a compact Ø12.7mm standard aluminum pin stub. The copper Faraday cup and aluminum pin stub can serve as a Cu/AI reference for detector gain/zero calibration. Intended for: light element performance test and EDS detector setup; includes: B, C, N, O and F in stable compounds.	Reference materials: C and CaF2. 200µm cop	
Au Resolution Sample Used for general resolution testing and imaging performance. This Gold on carbon resolution test standard has larger gold particles on a carbon substrate. The gold particles size ranges from 30-300nm. The carbon substrate is 6mm diameter with 2mm height. The larger gold particles provide excellent SE signal whereas the dark carbon background separates the individual gold particles.		

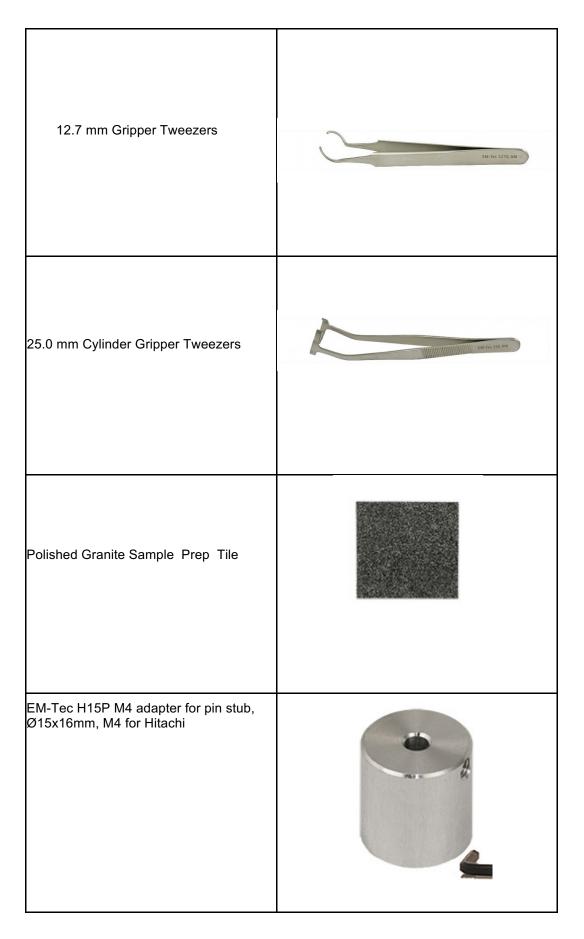
12.7 mm Pin Stubs	
Package of 50	
Hitachi Ø15x10mm M4 cylinder SEM sample stub, aluminum Package of 50	
Hitachi Ø25x6mm M4 cylinder SEM sample stub, aluminum	
Package of 50	





<u>Multi Pin Stub Holder</u> EM-Tec P4 multi pin stub holder for 4 pin stubs, Ø31.5x10.5mm, M4	
S-Clip 45/90 Sample Holder EM-Tec S-Clip sample holder with 2xS- Clips 45°/90° on Ø25 stub M4	
<u>S-clip 3X Holder</u> EM-Tec S-Clip sample holder with 3x S- Clips on Ø32x10mm stub, M4	12-004930-1 12-004930-2 12-004930-3

<u>Compact Vise Holder</u> EM-Tec V22 compact vise type sample holder for up to 22mm, M4, Neoscope	
Bulk Sample Holder	
EM-Tec R32 bulk sample holder for up to Ø32mm, aluminum, M4	
<u>Variable Tilt Holders</u> EM-Tec TV25 variable 0-90° angle tilt holder for stubs up Ø38mm, M4, Neoscope	



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